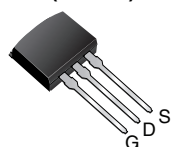
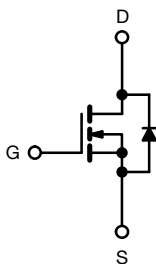
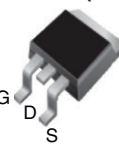


## Power MOSFET

I<sup>2</sup>PAK (TO-262)

D<sup>2</sup>PAK (TO-263)


N-Channel MOSFET

### PRODUCT SUMMARY

|                          |                        |      |
|--------------------------|------------------------|------|
| V <sub>DS</sub> (V)      | 500                    |      |
| R <sub>DS(on)</sub> (Ω)  | V <sub>GS</sub> = 10 V | 0.85 |
| Q <sub>g</sub> max. (nC) | 38                     |      |
| Q <sub>gs</sub> (nC)     | 9.0                    |      |
| Q <sub>gd</sub> (nC)     | 18                     |      |
| Configuration            | Single                 |      |

### FEATURES

- Low gate charge Q<sub>g</sub> results in simple drive requirement
- Improved gate, avalanche, and dynamic dV/dt ruggedness
- Fully characterized capacitance and avalanche voltage and current
- Effective C<sub>oss</sub> specified
- Material categorization: for definitions of compliance please see [www.vishay.com/doc?99912](http://www.vishay.com/doc?99912)



**RoHS\***  
Available  
**HALOGEN**  
**FREE**  
Available

### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

### APPLICATIONS

- Switch mode power supply (SMPS)
- Uninterruptible power supply
- High speed power switching

### TYPICAL SMPS TOPOLOGIES

- Two transistor forward
- Half bridge
- Full bridge

### ORDERING INFORMATION

| Package                         | D <sup>2</sup> PAK (TO-263) | D <sup>2</sup> PAK (TO-263)   | D <sup>2</sup> PAK (TO-263)   | I <sup>2</sup> PAK (TO-262) |
|---------------------------------|-----------------------------|-------------------------------|-------------------------------|-----------------------------|
| Lead (Pb)-free and Halogen-free | SiHF840AS-GE3               | SiHF840ASTRL-GE3 <sup>a</sup> | SiHF840ASTRR-GE3 <sup>a</sup> | SiHF840AL-GE3 <sup>a</sup>  |
| Lead (Pb)-free                  | IRF840ASPbF                 | IRF840ASTRLPbF <sup>a</sup>   | IRF840ASTRRPbF <sup>a</sup>   | IRF840ALPbF                 |

### Note

a. See device orientation

### ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25 °C, unless otherwise noted)

| PARAMETER                                        | SYMBOL                            | LIMIT                   | UNIT |
|--------------------------------------------------|-----------------------------------|-------------------------|------|
| Drain-Source Voltage                             | V <sub>DS</sub>                   | 500                     | V    |
| Gate-Source Voltage                              | V <sub>GS</sub>                   | ± 30                    |      |
| Continuous Drain Current                         | V <sub>GS</sub> at 10 V           | T <sub>C</sub> = 25 °C  | A    |
|                                                  |                                   | T <sub>C</sub> = 100 °C |      |
| Pulsed Drain Current <sup>a</sup>                | I <sub>DM</sub>                   | 32                      |      |
| Linear Derating Factor                           |                                   | 1.0                     | W/°C |
| Single Pulse Avalanche Energy <sup>b</sup>       | E <sub>AS</sub>                   | 510                     | mJ   |
| Repetitive Avalanche Current <sup>a</sup>        | I <sub>AR</sub>                   | 8.0                     | A    |
| Repetitive Avalanche Energy <sup>a</sup>         | E <sub>AR</sub>                   | 13                      | mJ   |
| Maximum Power Dissipation                        | P <sub>D</sub>                    | T <sub>C</sub> = 25 °C  | W    |
|                                                  |                                   | T <sub>A</sub> = 25 °C  |      |
| Peak Diode Recovery dV/dt <sup>c, e</sup>        | dV/dt                             | 5.0                     | V/ns |
| Operating Junction and Storage Temperature Range | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150             | °C   |
| Soldering Temperature <sup>d</sup>               | for 10 s                          | 300                     |      |

### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- Starting T<sub>J</sub> = 25 °C, L = 16 mH, R<sub>g</sub> = 25 Ω, I<sub>AS</sub> = 8.0 A (see fig. 12)
- I<sub>SD</sub> ≤ 8.0 A, dI/dt ≤ 100 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C
- 1.6 mm from case
- Uses IRF840A, SiHF840A data and test conditions

**THERMAL RESISTANCE RATINGS**

| PARAMETER                                            | SYMBOL     | MIN. | TYP. | MAX. | UNIT |
|------------------------------------------------------|------------|------|------|------|------|
| Maximum Junction-to-Ambient (PCB mount) <sup>a</sup> | $R_{thJA}$ | -    | -    | 40   | °C/W |
| Maximum Junction-to-Case (Drain)                     | $R_{thJC}$ | -    | -    | 1.0  |      |

**Note**

a. When mounted on 1" square PCB (FR-4 or G-10 material)

**SPECIFICATIONS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

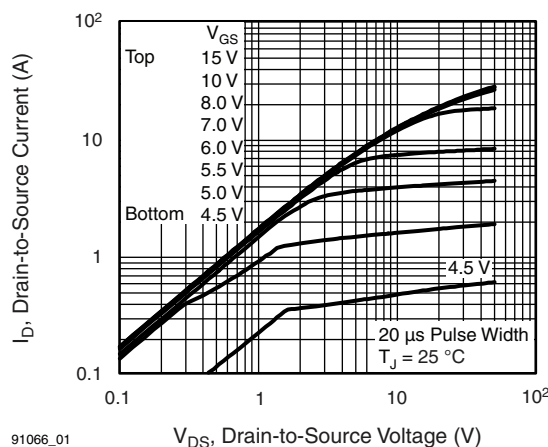
| PARAMETER                                      | SYMBOL              | TEST CONDITIONS                                                                                                                                                                             | MIN. | TYP. | MAX.      | UNIT          |
|------------------------------------------------|---------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|-----------|---------------|
| <b>Static</b>                                  |                     |                                                                                                                                                                                             |      |      |           |               |
| Drain-Source Breakdown Voltage                 | $V_{DS}$            | $V_{GS} = 0$ , $I_D = 250\ \mu\text{A}$                                                                                                                                                     | 500  | -    | -         | V             |
| $V_{DS}$ Temperature Coefficient               | $\Delta V_{DS}/T_J$ | Reference to $25^\circ\text{C}$ , $I_D = 1\ \text{mA}$ <sup>d</sup>                                                                                                                         | -    | 0.58 | -         | V/°C          |
| Gate-Source Threshold Voltage                  | $V_{GS(th)}$        | $V_{DS} = V_{GS}$ , $I_D = 250\ \mu\text{A}$                                                                                                                                                | 2.0  | -    | 4.0       | V             |
| Gate-Source Leakage                            | $I_{GSS}$           | $V_{GS} = \pm 30\ \text{V}$                                                                                                                                                                 | -    | -    | $\pm 100$ | nA            |
| Zero Gate Voltage Drain Current                | $I_{DSS}$           | $V_{DS} = 500\ \text{V}$ , $V_{GS} = 0\ \text{V}$                                                                                                                                           | -    | -    | 25        | $\mu\text{A}$ |
|                                                |                     | $V_{DS} = 400\ \text{V}$ , $V_{GS} = 0\ \text{V}$ , $T_J = 125^\circ\text{C}$                                                                                                               | -    | -    | 250       |               |
| Drain-Source On-State Resistance               | $R_{DS(on)}$        | $V_{GS} = 10\ \text{V}$ , $I_D = 4.8\ \text{A}$ <sup>b</sup>                                                                                                                                | -    | -    | 0.85      | $\Omega$      |
| Forward Transconductance                       | $g_{fs}$            | $V_{DS} = 50\ \text{V}$ , $I_D = 4.8\ \text{A}$                                                                                                                                             | 3.7  | -    | -         | S             |
| <b>Dynamic</b>                                 |                     |                                                                                                                                                                                             |      |      |           |               |
| Input Capacitance                              | $C_{iss}$           | $V_{GS} = 0\ \text{V}$ ,<br>$V_{DS} = 25\ \text{V}$ ,<br>$f = 1.0\ \text{MHz}$ , see fig. 5                                                                                                 | -    | 1018 | -         | pF            |
| Output Capacitance                             | $C_{oss}$           |                                                                                                                                                                                             | -    | 155  | -         |               |
| Reverse Transfer Capacitance                   | $C_{rss}$           |                                                                                                                                                                                             | -    | 8.0  | -         |               |
| Output Capacitance                             | $C_{oss}$           | $V_{GS} = 0\ \text{V}$<br>$V_{DS} = 1.0\ \text{V}$ , $f = 1.0\ \text{MHz}$<br>$V_{DS} = 400\ \text{V}$ , $f = 1.0\ \text{MHz}$<br>$V_{DS} = 0\ \text{V}$ to $480\ \text{V}$ <sup>c, d</sup> | -    | 1490 | -         |               |
| Output Capacitance                             | $C_{oss}$           |                                                                                                                                                                                             | -    | 42   | -         | nC            |
| Effective Output Capacitance                   | $C_{oss\ eff.}$     |                                                                                                                                                                                             | -    | 56   | -         |               |
| Total Gate Charge                              | $Q_g$               | $V_{GS} = 10\ \text{V}$<br>$I_D = 8.0\ \text{A}$ , $V_{DS} = 400\ \text{V}$ ,<br>see fig. 6 and 13 <sup>b, d</sup>                                                                          | -    | -    | 38        | nC            |
| Gate-Source Charge                             | $Q_{gs}$            |                                                                                                                                                                                             | -    | -    | 9.0       |               |
| Gate-Drain Charge                              | $Q_{gd}$            |                                                                                                                                                                                             | -    | -    | 18        |               |
| Turn-On Delay Time                             | $t_{d(on)}$         | $V_{DD} = 250\ \text{V}$ , $I_D = 8.0\ \text{A}$ ,<br>$R_g = 9.1\ \Omega$ , $R_D = 31\ \Omega$ , see fig. 10 <sup>b, d</sup>                                                                | -    | 11   | -         | ns            |
| Rise Time                                      | $t_r$               |                                                                                                                                                                                             | -    | 23   | -         |               |
| Turn-Off Delay Time                            | $t_{d(off)}$        |                                                                                                                                                                                             | -    | 26   | -         |               |
| Fall Time                                      | $t_f$               |                                                                                                                                                                                             | -    | 19   | -         |               |
| Gate Input Resistance                          | $R_g$               | $f = 1\ \text{MHz}$ , open drain                                                                                                                                                            | 0.7  | -    | 3.7       | $\Omega$      |
| <b>Drain-Source Body Diode Characteristics</b> |                     |                                                                                                                                                                                             |      |      |           |               |
| Continuous Source-Drain Diode Current          | $I_S$               | MOSFET symbol showing the integral reverse p - n junction diode                                        | -    | -    | 8.0       | A             |
| Pulsed Diode Forward Current <sup>a</sup>      | $I_{SM}$            |                                                                                                                                                                                             | -    | -    | 32        |               |
| Body Diode Voltage                             | $V_{SD}$            | $T_J = 25^\circ\text{C}$ , $I_S = 8.0\ \text{A}$ , $V_{GS} = 0\ \text{V}$ <sup>b</sup>                                                                                                      | -    | -    | 2.0       | V             |
| Body Diode Reverse Recovery Time               | $t_{rr}$            | $T_J = 25^\circ\text{C}$ , $I_F = 8.0\ \text{A}$ , $dI/dt = 100\ \text{A}/\mu\text{s}$ <sup>b</sup>                                                                                         | -    | 422  | 633       | ns            |
| Body Diode Reverse Recovery Charge             | $Q_{rr}$            |                                                                                                                                                                                             | -    | 2.0  | 3.0       | $\mu\text{C}$ |
| Forward Turn-On Time                           | $t_{on}$            | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )                                                                                                             |      |      |           |               |

**Notes**

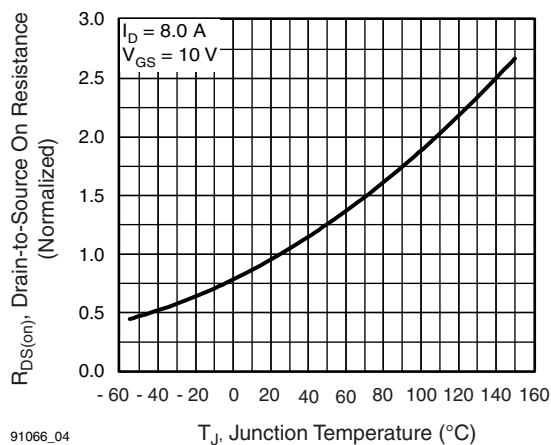
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)  
b. Pulse width  $\leq 300\ \mu\text{s}$ ; duty cycle  $\leq 2\ \%$   
c.  $C_{oss\ eff.}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$   
d. Uses IRF840A, SiHF840A data and test conditions



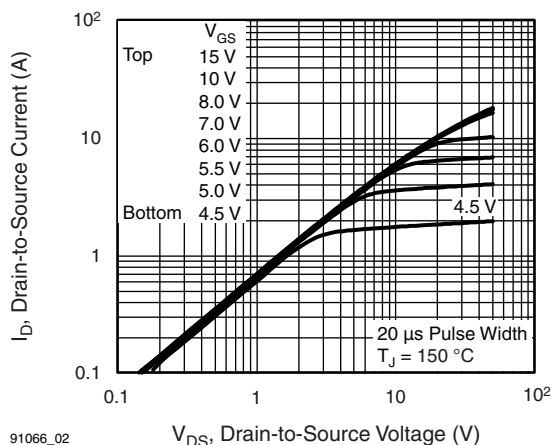
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



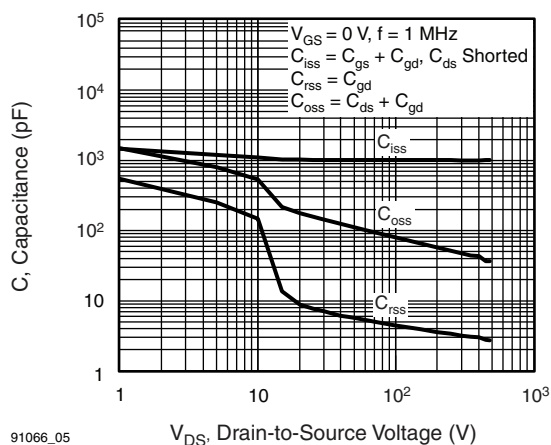
**Fig. 1 - Typical Output Characteristics**



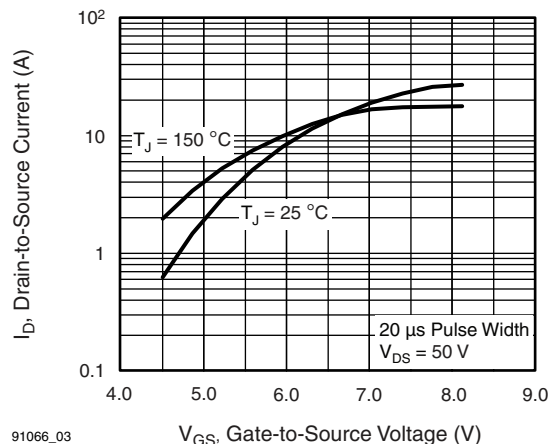
**Fig. 4 - Normalized On-Resistance vs. Temperature**



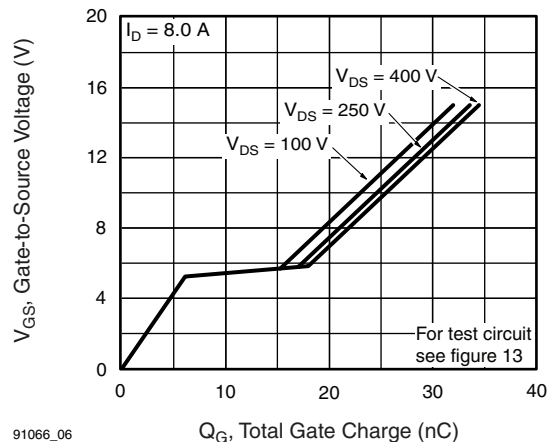
**Fig. 2 - Typical Output Characteristics**



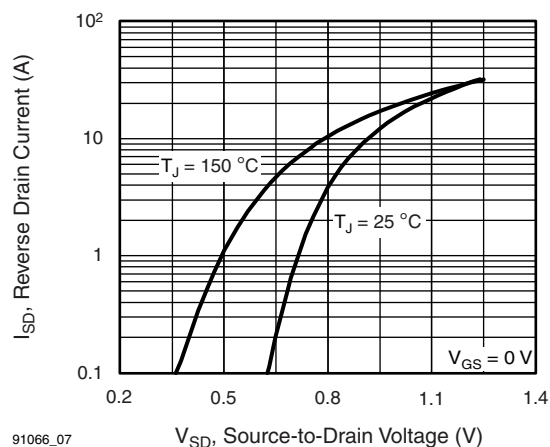
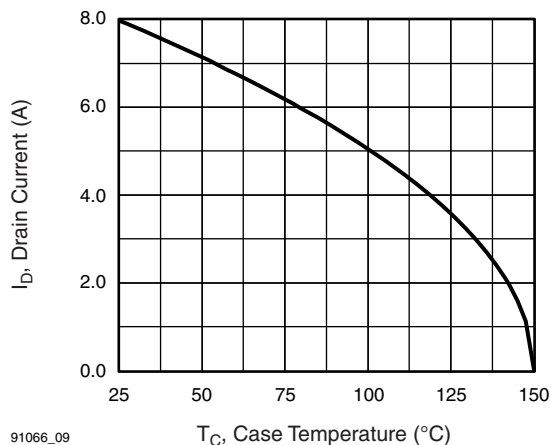
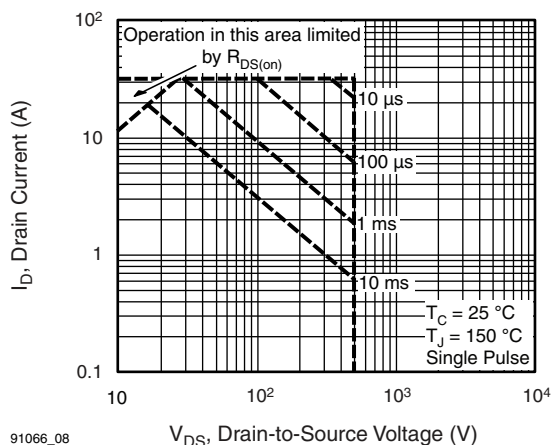
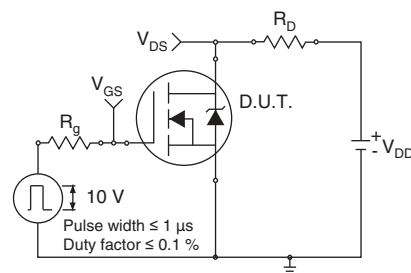
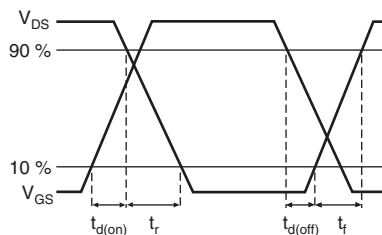
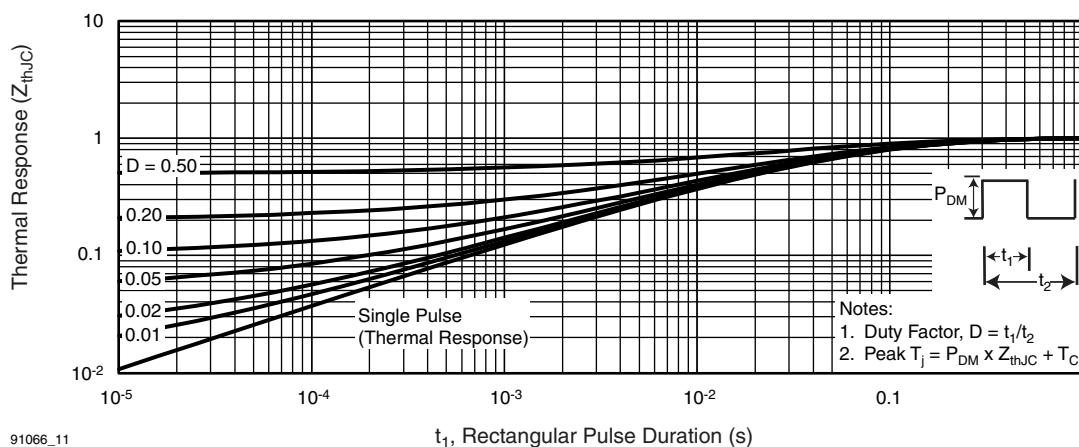
**Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage**

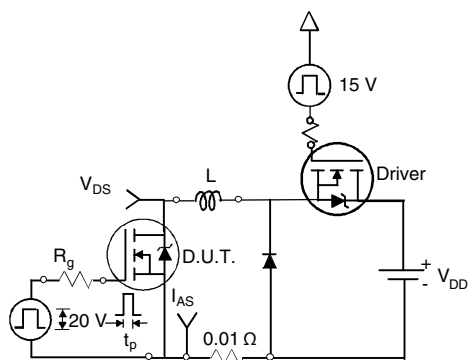


**Fig. 3 - Typical Transfer Characteristics**

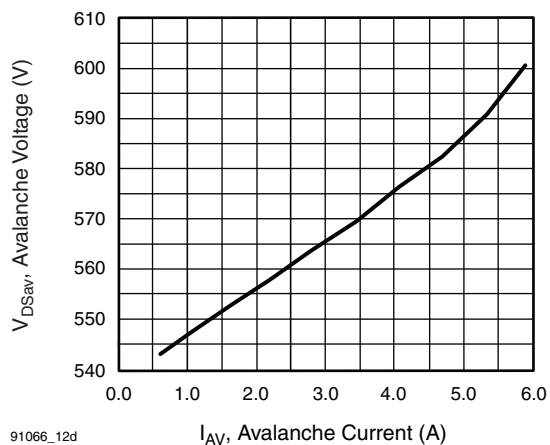


**Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage**

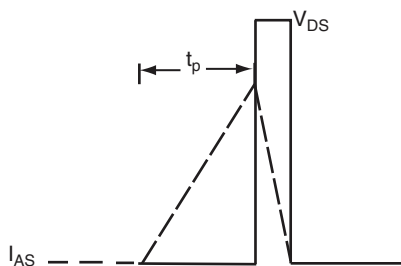

**Fig. 7 - Typical Source-Drain Diode Forward Voltage**

**Fig. 9 - Maximum Drain Current vs. Case Temperature**

**Fig. 8 - Maximum Safe Operating Area**

**Fig. 10a - Switching Time Test Circuit**

**Fig. 10b - Switching Time Waveforms**

**Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**



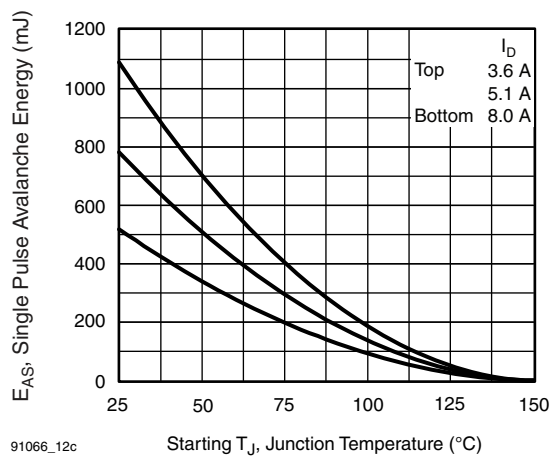
**Fig. 12a - Unclamped Inductive Test Circuit**



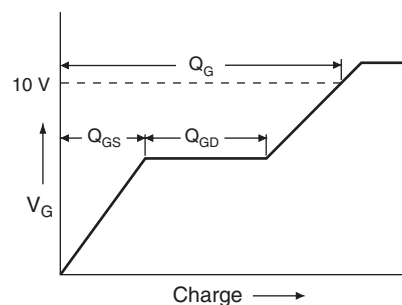
**Fig. 12d - Typical Drain-to-Source Voltage vs. Avalanche Current**



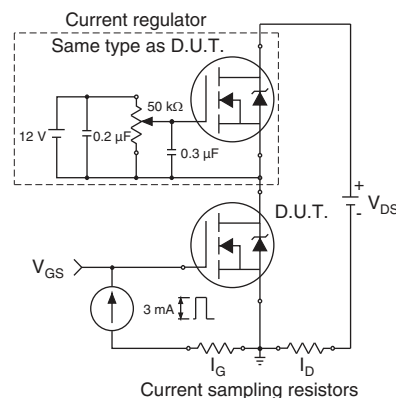
**Fig. 12b - Unclamped Inductive Waveforms**



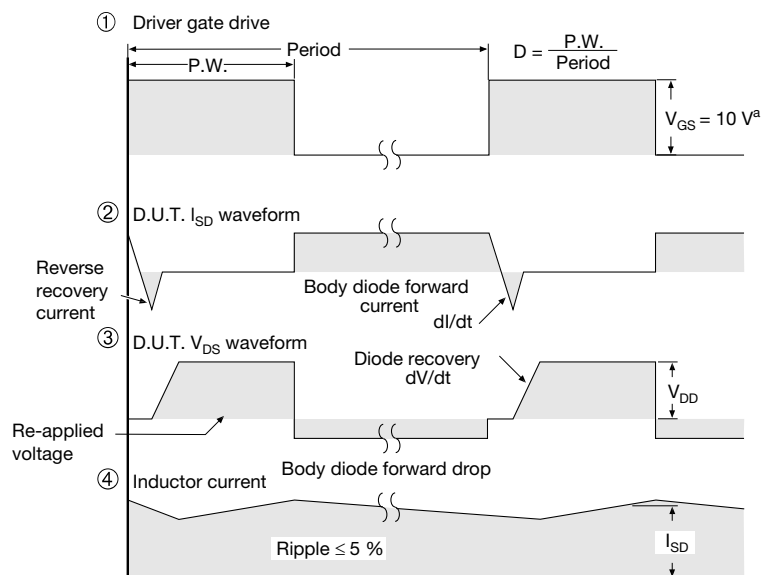
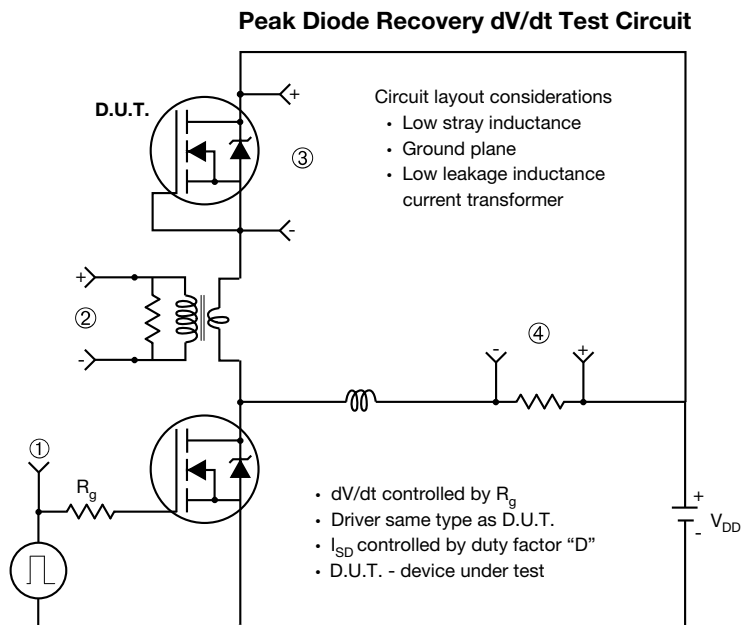
**Fig. 12c - Maximum Avalanche Energy vs. Drain Current**



**Fig. 13a - Basic Gate Charge Waveform**



**Fig. 13b - Gate Charge Test Circuit**



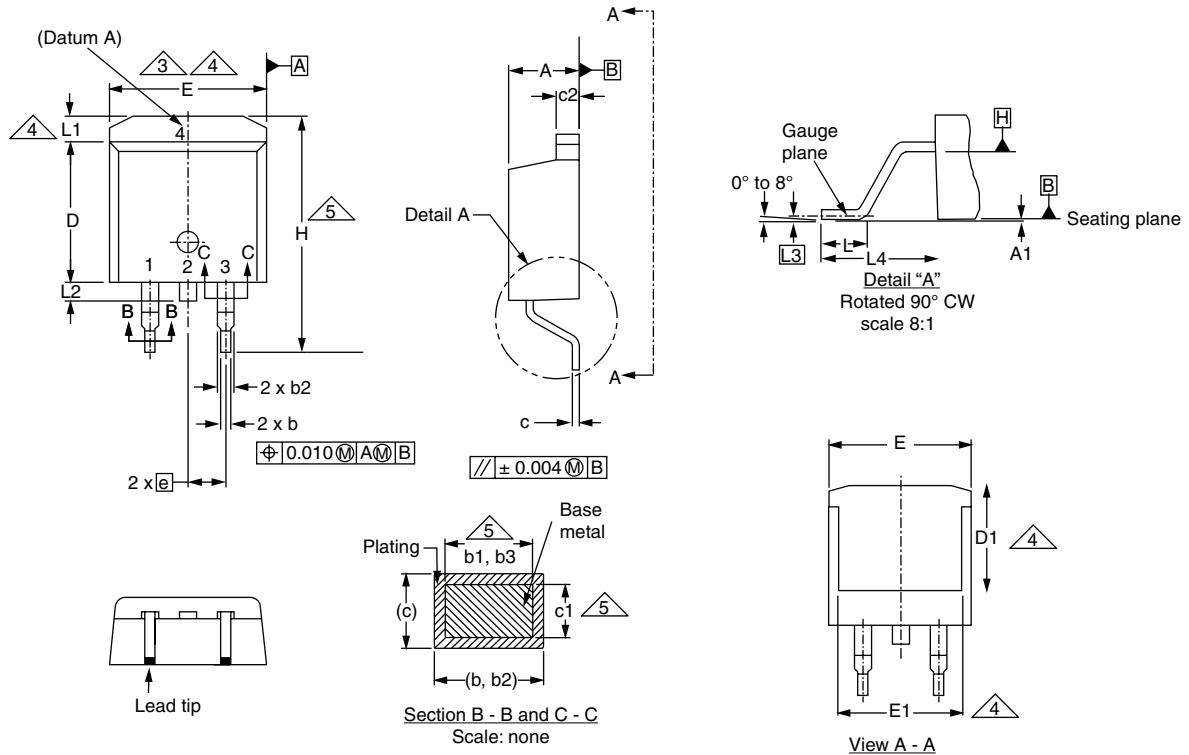
**Note**

a.  $V_{GS} = 5 V$  for logic level devices

**Fig. 14 - For N-Channel**

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### TO-263AB (HIGH VOLTAGE)



| DIM. | MILLIMETERS |      | INCHES |       |
|------|-------------|------|--------|-------|
|      | MIN.        | MAX. | MIN.   | MAX.  |
| A    | 4.06        | 4.83 | 0.160  | 0.190 |
| A1   | 0.00        | 0.25 | 0.000  | 0.010 |
| b    | 0.51        | 0.99 | 0.020  | 0.039 |
| b1   | 0.51        | 0.89 | 0.020  | 0.035 |
| b2   | 1.14        | 1.78 | 0.045  | 0.070 |
| b3   | 1.14        | 1.73 | 0.045  | 0.068 |
| c    | 0.38        | 0.74 | 0.015  | 0.029 |
| c1   | 0.38        | 0.58 | 0.015  | 0.023 |
| c2   | 1.14        | 1.65 | 0.045  | 0.065 |
| D    | 8.38        | 9.65 | 0.330  | 0.380 |

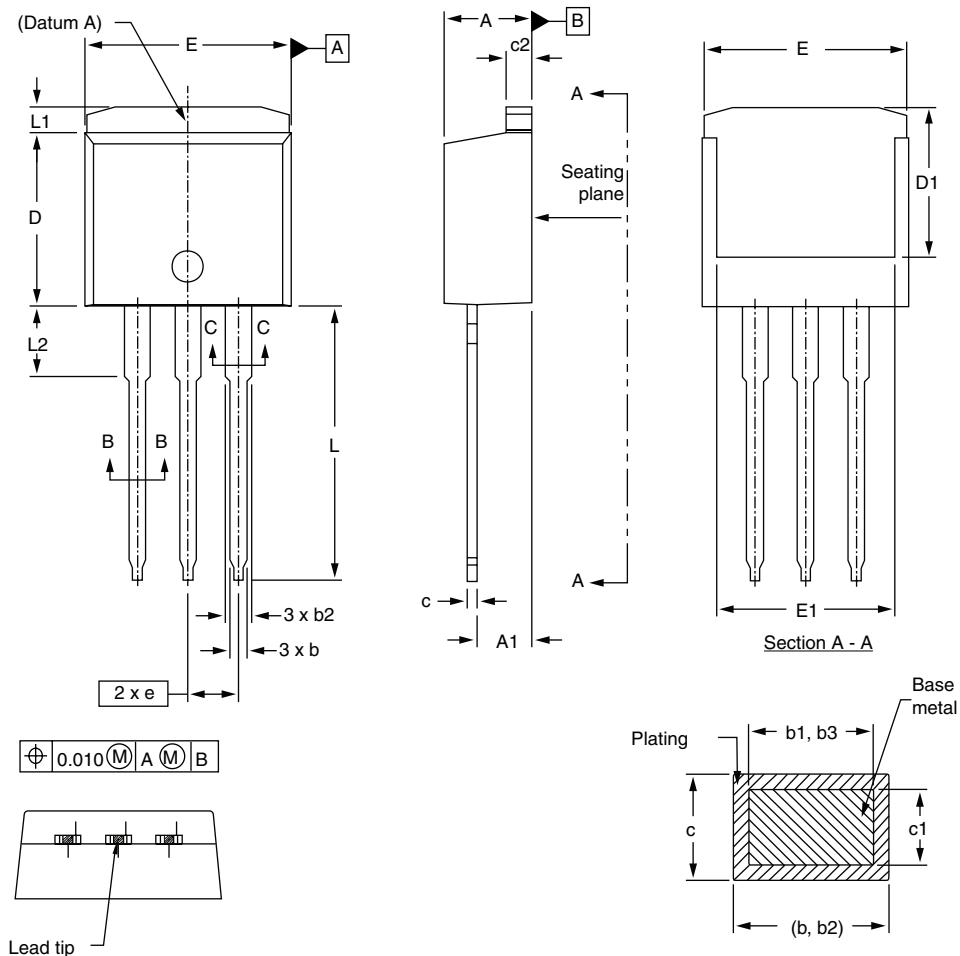
| DIM. | MILLIMETERS |       | INCHES    |       |
|------|-------------|-------|-----------|-------|
|      | MIN.        | MAX.  | MIN.      | MAX.  |
| D1   | 6.86        | -     | 0.270     | -     |
| E    | 9.65        | 10.67 | 0.380     | 0.420 |
| E1   | 6.22        | -     | 0.245     | -     |
| e    | 2.54 BSC    |       | 0.100 BSC |       |
| H    | 14.61       | 15.88 | 0.575     | 0.625 |
| L    | 1.78        | 2.79  | 0.070     | 0.110 |
| L1   | -           | 1.65  | -         | 0.066 |
| L2   | -           | 1.78  | -         | 0.070 |
| L3   | 0.25 BSC    |       | 0.010 BSC |       |
| L4   | 4.78        | 5.28  | 0.188     | 0.208 |

ECN: S-82110-Rev. A, 15-Sep-08  
DWG: 5970

#### Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Dimensions are shown in millimeters (inches).
3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
5. Dimension b1 and c1 apply to base metal only.
6. Datum A and B to be determined at datum plane H.
7. Outline conforms to JEDEC outline to TO-263AB.

## I<sup>2</sup>PAK (TO-262) (HIGH VOLTAGE)



|      | MILLIMETERS |      | INCHES |       |
|------|-------------|------|--------|-------|
| DIM. | MIN.        | MAX. | MIN.   | MAX.  |
| A    | 4.06        | 4.83 | 0.160  | 0.190 |
| A1   | 2.03        | 3.02 | 0.080  | 0.119 |
| b    | 0.51        | 0.99 | 0.020  | 0.039 |
| b1   | 0.51        | 0.89 | 0.020  | 0.035 |
| b2   | 1.14        | 1.78 | 0.045  | 0.070 |
| b3   | 1.14        | 1.73 | 0.045  | 0.068 |
| c    | 0.38        | 0.74 | 0.015  | 0.029 |
| c1   | 0.38        | 0.58 | 0.015  | 0.023 |
| c2   | 1.14        | 1.65 | 0.045  | 0.065 |

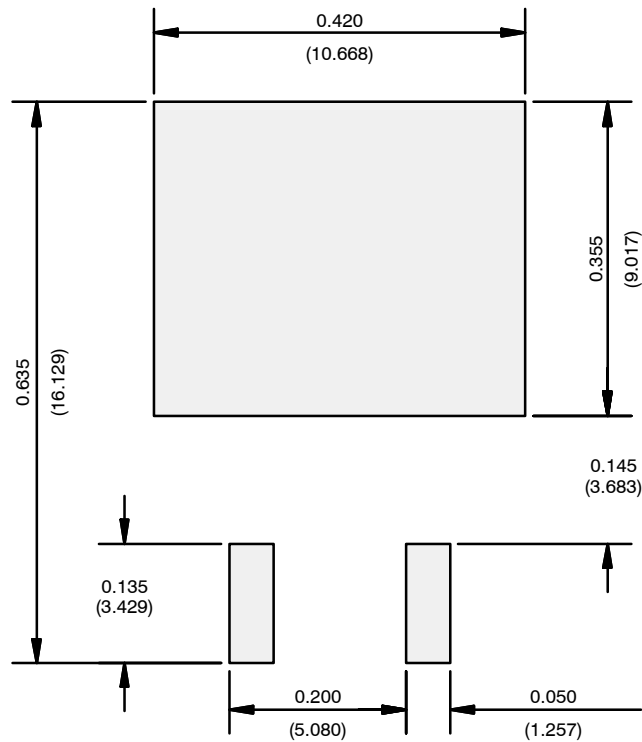
|      | MILLIMETERS |       | INCHES    |       |
|------|-------------|-------|-----------|-------|
| DIM. | MIN.        | MAX.  | MIN.      | MAX.  |
| D    | 8.38        | 9.65  | 0.330     | 0.380 |
| D1   | 6.86        | -     | 0.270     | -     |
| E    | 9.65        | 10.67 | 0.380     | 0.420 |
| E1   | 6.22        | -     | 0.245     | -     |
| e    | 2.54 BSC    |       | 0.100 BSC |       |
| L    | 13.46       | 14.10 | 0.530     | 0.555 |
| L1   | -           | 1.65  | -         | 0.065 |
| L2   | 3.56        | 3.71  | 0.140     | 0.146 |

ECN: S-82442-Rev. A, 27-Oct-08  
DWG: 5977

### Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
3. Thermal pad contour optional within dimension E, L1, D1, and E1.
4. Dimension b1 and c1 apply to base metal only.

**RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**



Recommended Minimum Pads  
Dimensions in Inches/(mm)

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